## Search Notes



Application/Control No.	Applicant(s)/Patent Under Reexamination	
10689355	BEAUMONT, MARK	
Examiner	Art Unit	
Wai, Eric C	2195	

SEARCHED				
Class	Subclass	Date	Examiner	
718	105	07/20/2007	ECW	
370	16	07/20/2007	ECW	
395	765	07/20/2007	ECW	
709	225	07/20/2007	ECW	

SEARCH NOTES				
Search Notes	Date	Examiner		
East Search	07/20/2007	ECW		
Inventor's Name Search	07/20/2007	ECW		

INTERFERENCE SEARCH				
Class	Subclass	Date	Examine	

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